

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/615,791 | Applicant(s)/Patent Under Reexamination SHIOTA, TAKESHI | |
| | Examiner Erick Rekstad | Art Unit 2621 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------|----------------|
| * | A | US-6,917,176 | 07-2005 | Schempf et al. | 318/568.11 |
| * | B | US-4,537,136 | 08-1985 | Douglas, Brian | 104/138.2 |
| * | C | US-3,761,623 | 09-1973 | Hara et al. | 348/84 |
| * | D | US-5,650,579 | 07-1997 | Hatley et al. | 73/865.8 |
| * | E | US-6,887,014 | 05-2005 | Holland, Cal | 405/184.1 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.